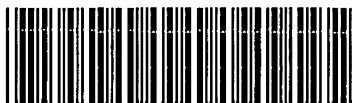


Search Notes

Application/Control No.

10/696,294

Examiner

Y. Lee

Applicant(s)/Patent under
Reexamination

YONEYAMA, AKIRA

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
375	240.01 240.12 240.13 240.16	5/23/2006	YL
	240.23		
	240.25		
	240.26		
H04N	7/12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	240.16	5/23/2006	YL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR